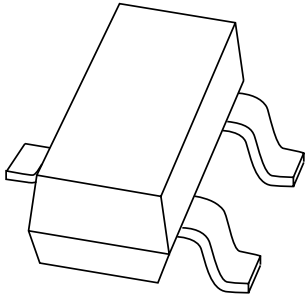


# DATA SHEET



**BAV199**

Low-leakage double diode

Product data sheet  
Supersedes data of 1999 May 11

2001 Oct 12

# Low-leakage double diode

# BAV199

### FEATURES

- Plastic SMD package
- Low leakage current: typ. 3 pA
- Switching time: typ. 0.8 μs
- Continuous reverse voltage: max. 75 V
- Repetitive peak reverse voltage: max. 85 V
- Repetitive peak forward current: max. 500 mA.

### APPLICATION

- Low-leakage current applications in surface mounted circuits.

### DESCRIPTION

Epitaxial, medium-speed switching, double diode in a small SOT23 plastic SMD package. The diodes are connected in series.

### MARKING

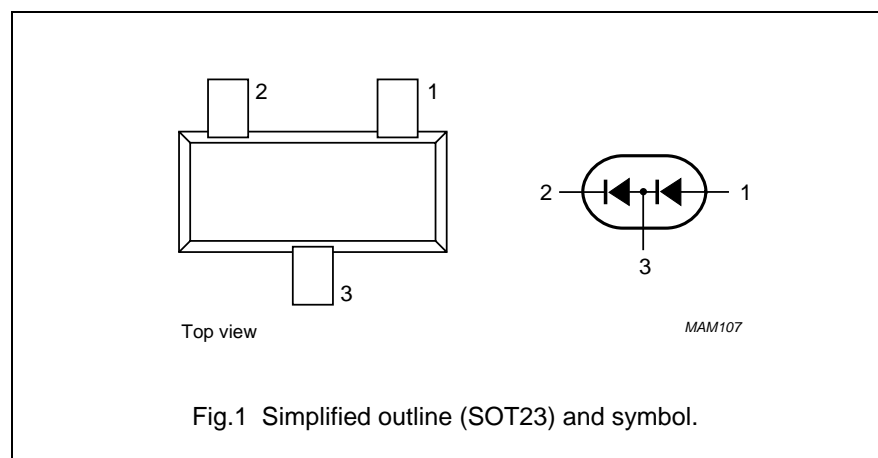
| TYPE NUMBER | MARKING CODE <sup>(1)</sup> |
|-------------|-----------------------------|
| BAV199      | JY*                         |

#### Note

1. \* = p: Made in Hong Kong.  
\* = t: Made in Malaysia.  
\* = W: Made in China.

### PINNING

| PIN | DESCRIPTION    |
|-----|----------------|
| 1   | anode          |
| 2   | cathode        |
| 3   | anode; cathode |



### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL           | PARAMETER                           | CONDITIONS  | MIN. | MAX. | UNIT |
|------------------|-------------------------------------|---|------|------|------|
| <b>Per diode</b> |                                     |   |      |      |      |
| V <sub>RRM</sub> | repetitive peak reverse voltage     |   | –    | 85   | V    |
| V <sub>R</sub>   | continuous reverse voltage          |   | –    | 75   | V    |
| I <sub>F</sub>   | continuous forward current          | single diode loaded; note 1; see Fig.2                        | –    | 160  | mA   |
|                  |                                     | double diode loaded; note 1; see Fig.2                        | –    | 140  | mA   |
| I <sub>FRM</sub> | repetitive peak forward current     |   | –    | 500  | mA   |
| I <sub>FSM</sub> | non-repetitive peak forward current | square wave; T <sub>j</sub> = 25 °C prior to surge; see Fig.4 |      |      |      |
|                  |                                     | t <sub>p</sub> = 1 μs   | –    | 4    | A    |
|                  |                                     | t <sub>p</sub> = 1 ms   | –    | 1    | A    |
|                  |                                     | t <sub>p</sub> = 1 s  | –    | 0.5  | A    |
| P <sub>tot</sub> | total power dissipation             | T <sub>amb</sub> = 25 °C; note 1                              | –    | 250  | mW   |
| T <sub>stg</sub> | storage temperature                 |   | –65  | +150 | °C   |
| T <sub>j</sub>   | junction temperature                |   | –    | 150  | °C   |

#### Note

1. Device mounted on a FR4 printed-circuit board.

## Low-leakage double diode

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**ELECTRICAL CHARACTERISTICS** $T_j = 25\text{ °C}$  unless otherwise specified.

| SYMBOL           | PARAMETER             | CONDITIONS  | TYP.  | MAX. | UNIT          |
|------------------|-----------------------|---|-------|------|---------------|
| <b>Per diode</b> |                       |   |       |      |               |
| $V_F$            | forward voltage       | see Fig.3   |       |      |               |
|                  |                       | $I_F = 1\text{ mA}$   | –     | 900  | mV            |
|                  |                       | $I_F = 10\text{ mA}$  | –     | 1000 | mV            |
|                  |                       | $I_F = 50\text{ mA}$  | –     | 1100 | mV            |
|                  |                       | $I_F = 150\text{ mA}$   | –     | 1250 | mV            |
| $I_R$            | reverse current       | see Fig.5   |       |      |               |
|                  |                       | $V_R = 75\text{ V}$   | 0.003 | 5    | nA            |
|                  |                       | $V_R = 75\text{ V}; T_j = 150\text{ °C}$  | 3     | 80   | nA            |
| $C_d$            | diode capacitance     | $f = 1\text{ MHz}; V_R = 0$ ; see Fig.6   | 2     | –    | pF            |
| $t_{rr}$         | reverse recovery time | when switched from $I_F = 10\text{ mA}$ to $I_R = 10\text{ mA}$ ; $R_L = 100\ \Omega$ ; measured at $I_R = 1\text{ mA}$ ; see Fig.7 | 0.8   | 3    | $\mu\text{s}$ |

**THERMAL CHARACTERISTICS**

| SYMBOL         | PARAMETER                                     | CONDITIONS | VALUE | UNIT |
|----------------|---|------------|-------|------|
| $R_{th\ j-tp}$ | thermal resistance from junction to tie-point |            | 360   | K/W  |
| $R_{th\ j-a}$  | thermal resistance from junction to ambient   | note 1     | 500   | K/W  |

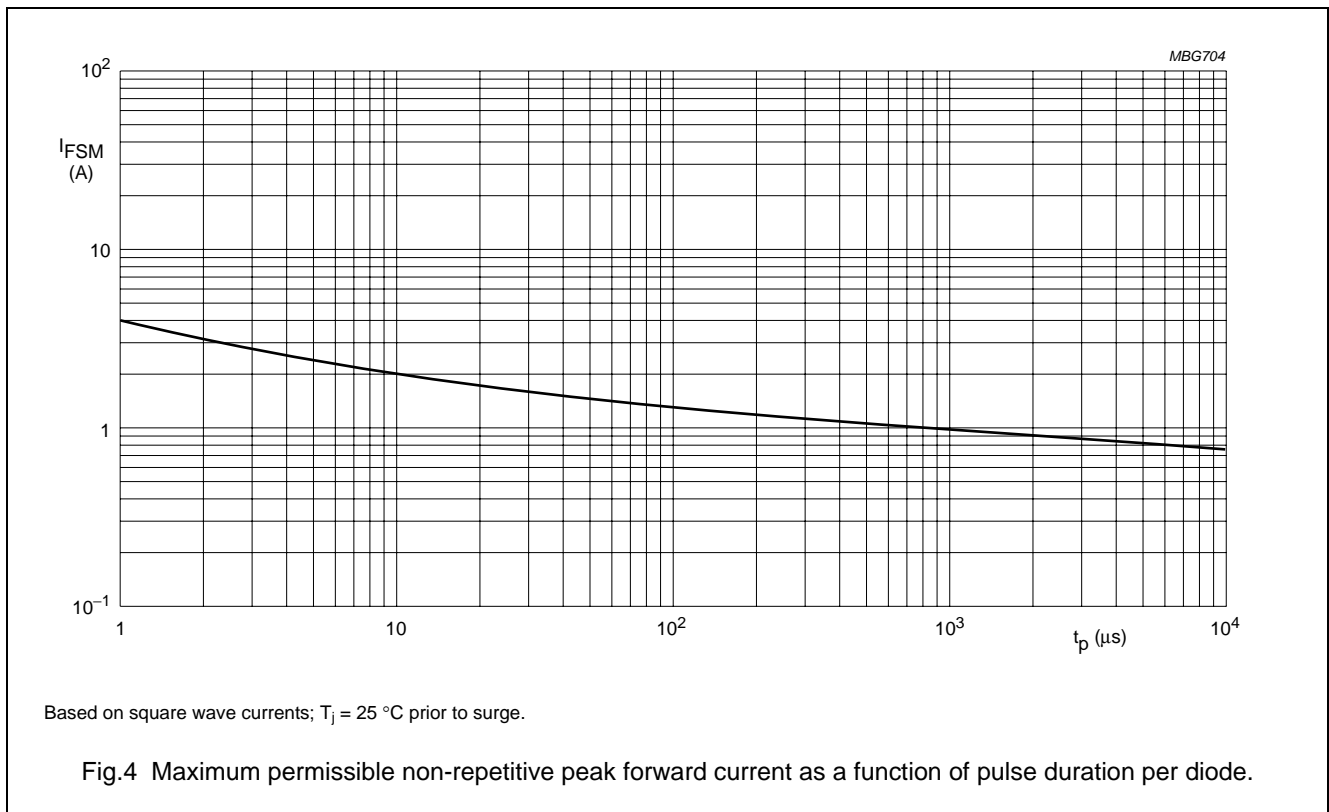
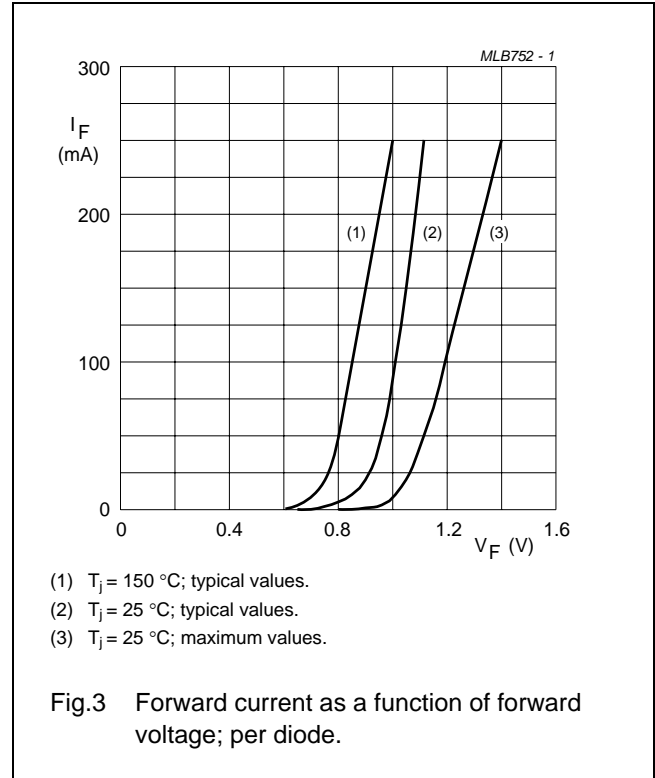
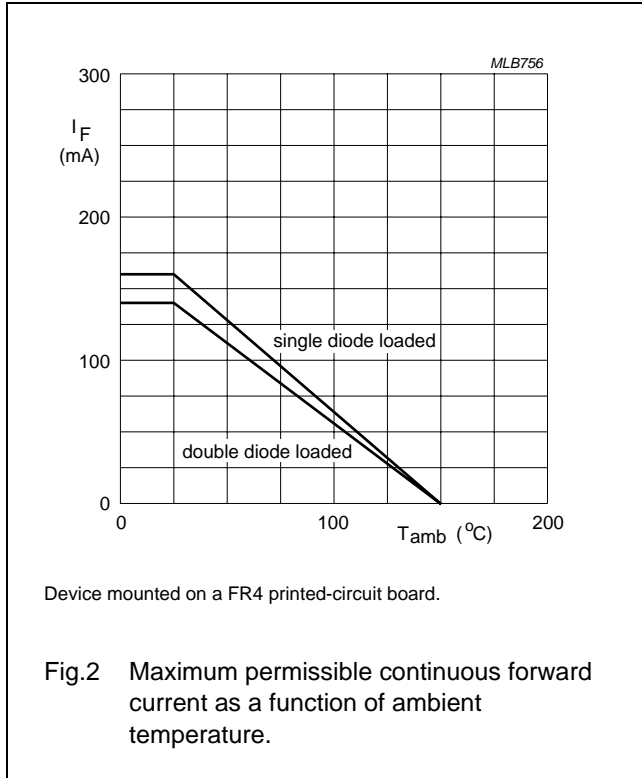
**Note**

1. Device mounted on a FR4 printed-circuit board.

Low-leakage double diode

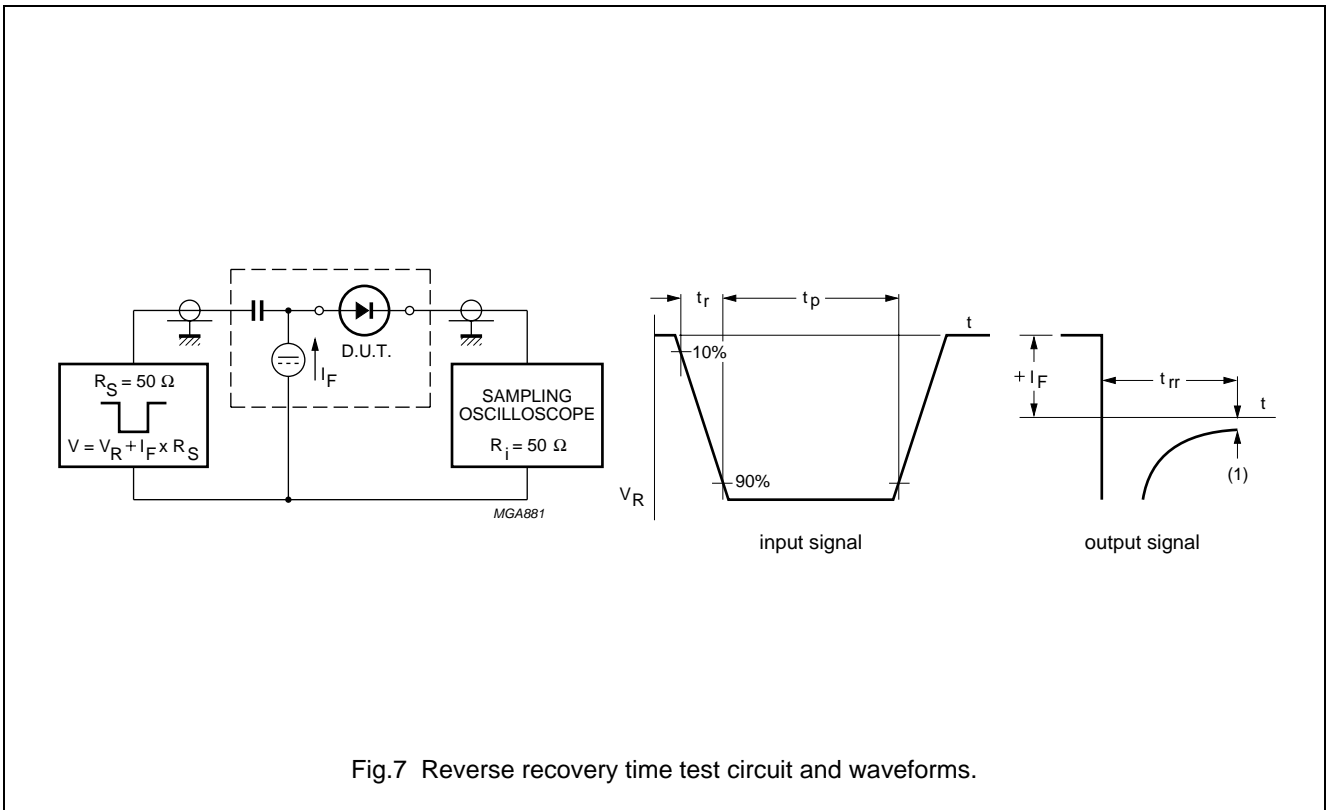
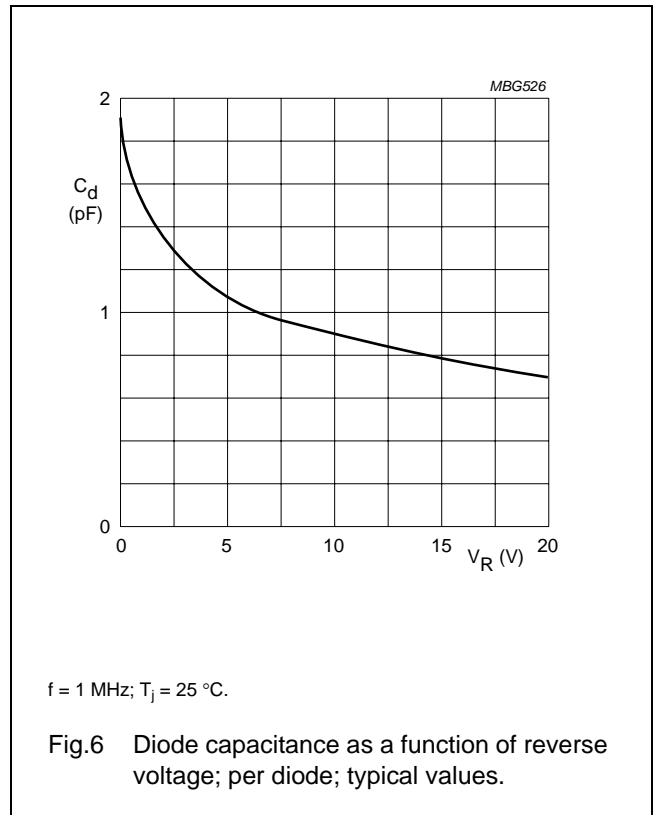
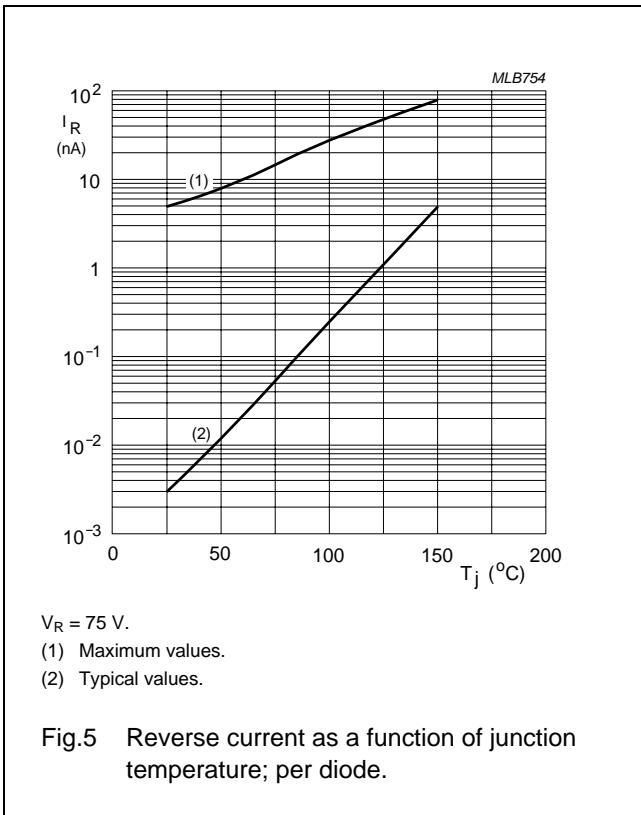
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GRAPHICAL DATA



Low-leakage double diode

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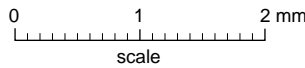
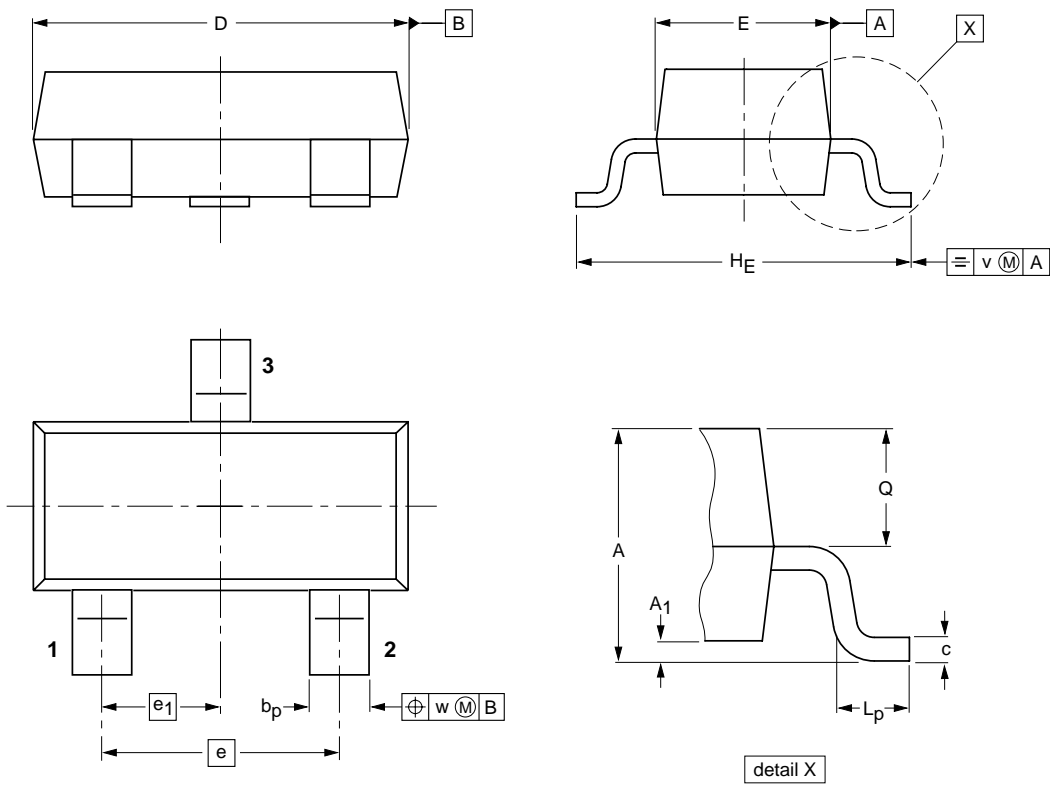
Low-leakage double diode

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PACKAGE OUTLINE

Plastic surface mounted package; 3 leads

SOT23



DIMENSIONS (mm are the original dimensions)

| UNIT | A          | A <sub>1</sub><br>max. | b <sub>p</sub> | c            | D          | E          | e   | e <sub>1</sub> | H <sub>E</sub> | L <sub>p</sub> | Q            | v   | w   |
|------|------------|------------------------|----------------|--------------|------------|------------|-----|----------------|----------------|----------------|--------------|-----|-----|
| mm   | 1.1<br>0.9 | 0.1                    | 0.48<br>0.38   | 0.15<br>0.09 | 3.0<br>2.8 | 1.4<br>1.2 | 1.9 | 0.95           | 2.5<br>2.1     | 0.45<br>0.15   | 0.55<br>0.45 | 0.2 | 0.1 |

| OUTLINE VERSION | REFERENCES |          |      | EUROPEAN PROJECTION | ISSUE DATE           |
|-----------------|------------|----------|------|---------------------|----------------------|
|                 | IEC        | JEDEC    | EIAJ |                     |                      |
| SOT23           |            | TO-236AB |      |                     | 97-02-28<br>99-09-13 |

# Low-leakage double diode

BAV199

## DATA SHEET STATUS

| DOCUMENT STATUS <sup>(1)</sup> | PRODUCT STATUS <sup>(2)</sup> | DEFINITION  |
|--------------------------------|-------------------------------|---|
| Objective data sheet           | Development                   | This document contains data from the objective specification for product development. |
| Preliminary data sheet         | Qualification                 | This document contains data from the preliminary specification.                       |
| Product data sheet             | Production                    | This document contains the product specification.                                     |

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